TEST REPORT

Applicant:	Seeed Technology Co., Ltd
Address:	9F, Building G3, TCL International E city, Shuguang Community, Xili street, Nanshan, Shenzhen, Guangdong Province, P.R.C
Equipment Type:	reComputer Industrial R2200
Model Name:	reComputer Industrial R2245-12 (refer to section 2.3)
Brand Name:	Seeed Studio
Test Standard:	47 CFR Part 15 Subpart B ANSI C63.4-2014
Sample Arrival Date:	Dec. 18, 2025
Test Date:	Jan. 05, 2026 - Jan. 06, 2026
Date of Issue:	Mar. 12, 2026

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Liu Chenfang **Checked by:** Xiong Chong **Approved by:** Tolan Tu (Testing Director)

Revision History

Version	Issue Date	Revisions
Rev. 01	Mar. 12, 2026	Initial Issue

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☐ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☑ Building 2, Intelligent Connected Vehicle Industrial Park, No. 55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196.The certification body is American Association for Laboratory Accreditation (A2LA).

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Seeed Technology Co., Ltd
Address	9F, Building G3, TCL International E city, Shuguang Community, Xili street, Nanshan, Shenzhen, Guangdong Province, P.R.C

2.2 Manufacturer Information

Manufacturer	Seeed Technology Co., Ltd
Address	9F, Building G3, TCL International E city, Shuguang Community, Xili street, Nanshan, Shenzhen, Guangdong Province, P.R.C

2.3 General Description for Equipment under Test (EUT)

EUT Name	reComputer Industrial R2200
Model Name Under Test	reComputer Industrial R2245-12
Series Model Name	reComputer Industrial R2235-12
Description of Model name differentiation	All models are same with electrical parameters and internal circuit structure, but only differ in Memory and model name. (this information provided by the applicant)
Hardware Version	N/A
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.4 Ancillary Equipment

Ancillary Equipment 1	Adapter	
	Brand Name	N/A
	Model No.	PA-1900-32
	Serial No.	N/A
	Rated Input	100-240 V~, 1.5A, 50/60 Hz
	Rated Output	19.0V⎓4.74A
Ancillary Equipment 2	Antenna	
Ancillary Equipment 3	DC Cable	
	Length (Approx.)	0.25m

2.5 Technical Information

Network and Wireless connectivity	Bluetooth, WIFI
Classification of equipment	Class B
The highest internal frequency of EUT	5.7 GHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Remark
1	Radiated Emission	15.109	Pass	--
2	Conducted Emission, AC Ports	15.107	Pass	--

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.2 dB
Radiated emissions (30 MHz-1 GHz)-966#5	4.7 dB
Radiated emissions (1 GHz-18 GHz)-966#5	5.0 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Enclosure List

Description	Manufacturer	Model	Serial No.	Length	Description	Use
PoE Simulated Load	N/A	N/A	N/A	N/A	provided by the customer	☒
Monitor	HUAWEI	XWU-CAA	N/A	N/A	N/A	☒
Monitor	HUAWEI	HSN-CBA	N/A	N/A	N/A	☒
Monitor	PHILIPS	241V8W	N/A	N/A	N/A	☒
Mouse	Niye	M508	N/A	N/A	N/A	☒
Keyboard	Dell	KB216d1	N/A	N/A	N/A	☒
HDMI Cable	UGREEN	N/A	N/A	1.5m	Unshielded with core	☒
RJ45 Cable	UGREEN	N/A	N/A	1.5m	Unshielded with core	☒
USB Hard Drive	WD Element	N/A	N/A	N/A	N/A	☒
Type-C Hard Drive	WD Element	N/A	N/A	N/A	N/A	☒
Earphone	OPPO	N/A	N/A	1.2m	N/A	☒
Laptop	Lenovo	ZhaoYang K4e-IAP	N/A	N/A	N/A	☒
Power Cable	N/A	N/A	N/A	N/A	provided by the customer	☒

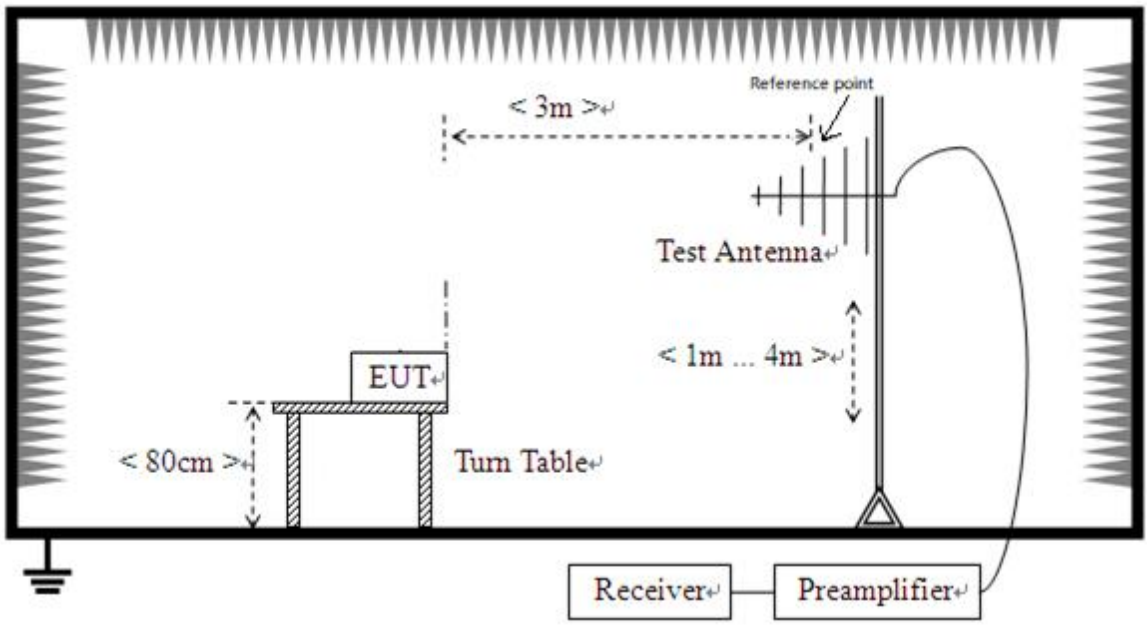
4.2 Test Configurations

All test modes of EUT are listed in the table below.

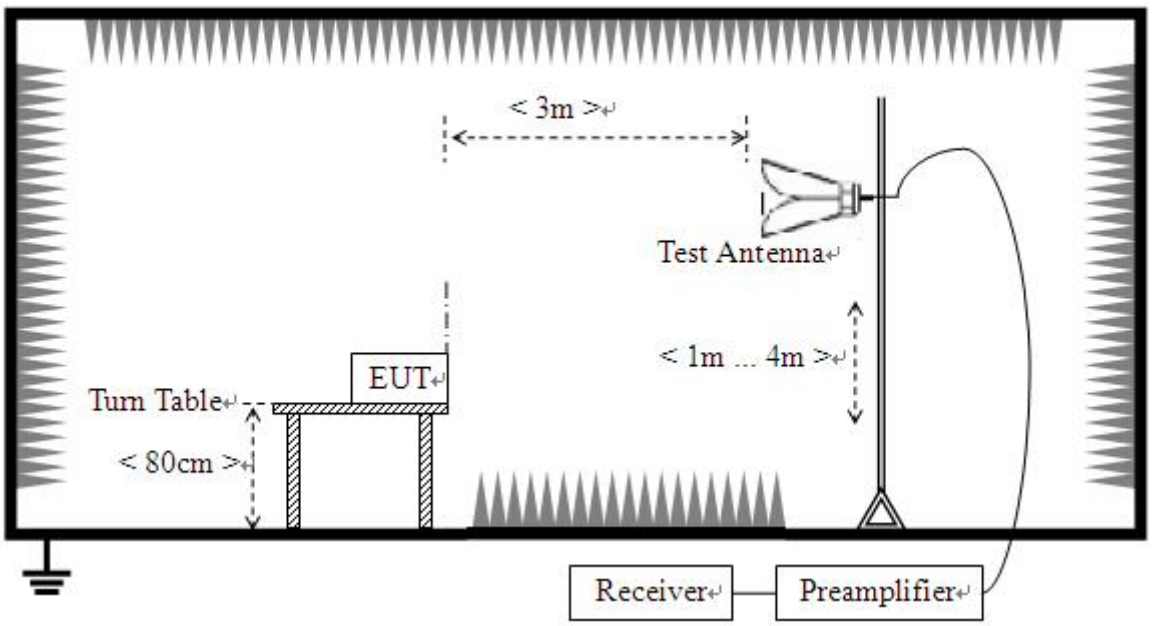
Test Mode Configuration	Description
Mode 1	The Working Test Mode EUT + DC Cable + Adapter + Power Cable + PoE Simulated Load + RJ45 Cable + Laptop + USB Hard Drive + Type-C Hard Drive + HDMI Cable + Monitor + Earphone + Mouse + Keyboard + Antenna

4.3 Test Setups

Test Setup 1

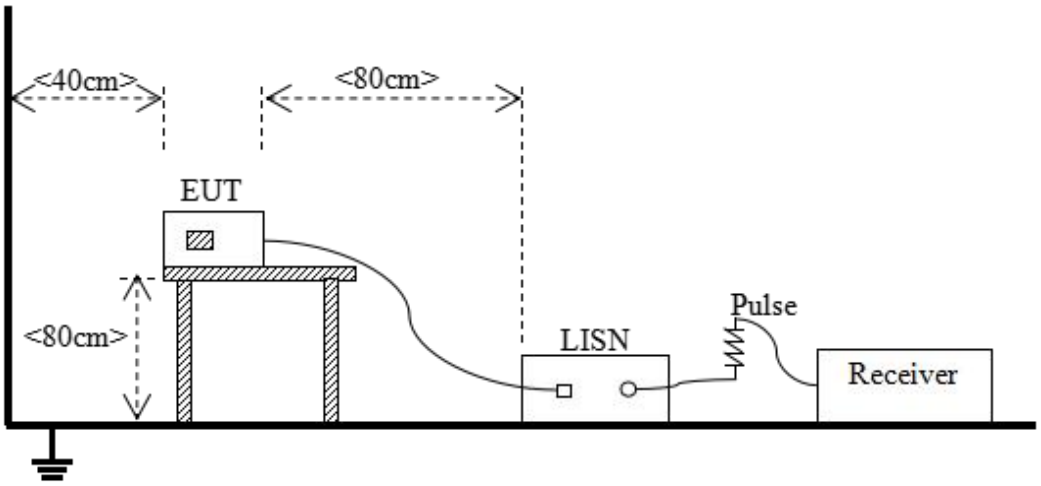


Radiated Emission (30 MHz-1 GHz)



Radiated Emission (above 1 GHz)

Test Setup 2



Conducted Emissions, AC Ports

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class A (at 3 m)
	Field Strength (μV/m)	Field Strength (dBμV/m)	Field Strength (dBμV/m)
30 - 88	100	40	49.5
88 - 216	150	43.5	54
216 - 960	200	46	56.9
Above 960	500	54	60

NOTE:
1) Field Strength (dBμV/m) = 20*log [Field Strength (μV/m)].
2) In the emission tables above, the tighter limit applies at the band edges.
3) For 30 MHz to 1000 MHz, the CISPR quasi-peak is employed.

For above 1000 MHz, according to the requirements of FCC 15.35, unless otherwise specified, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency range (GHz)	Class B (at 3 m)			Class A (at 3 m)	
	Field Strength (μV/m)	Field Strength Average (dBμV/m)	Field Strength Peak (dBμV/m)	Field Strength Average (dBμV/m)	Field Strength Peak (dBμV/m)
1 - F_M	500	54	74	60	80

Note 1: The highest measurement frequency, F_M, in GHz, shall be determined as next Table.
Note 2: Average Class A limit at 3m L_{3m} is determined by the following conversion formula:
$L_{3m} = L_{10m} + 20*\log(d_{10m}/d_{3m})$
Where:
L_{3m} is Average Class A limit at 3m;
L_{10m} is Average Class A limit at 10m;
d_{10m} is Measurement distance in 10m;
d_{3m} is Measurement distance in 3m.
For this case: L_{3m} = 49.5 + 20*log(10/3)=60 (dBμV/m).

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108$ MHz	1 GHz
108 MHz ≤ $F_X \leq 500$ MHz	2 GHz
500 MHz ≤ $F_X \leq 1$ GHz	5 GHz
$F_X \geq 1$ GHz	5 *F_X or 40 GHz, whichever is lower.
Note: F_X is Highest frequency generated or used in the device or on which the device operates or tunes.	

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Radiated Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for f ≥ 1 GHz, 100 kHz for f < 1 GHz

VBW ≥ RBW

Sweep = auto

Detector function = peak for f <1 GHz, peak & RMS Average for f ≥ 1 GHz

Trace = max hold

5.1.1.4 Test Result and Test Equipment List

Please refer to ANNEX A.1.

NOTE:

1. Results (dBμV/m) = Reading (dBμV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Margin = Limit - Results

5.1.2 Conducted Emission, AC Ports

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dBμV)	Average (dBμV)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dBμV)	Average (dBμV)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

1) The lower limit shall apply at the band edges.
2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 2) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω/50 μH of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW ≥ RBW

Sweep = 10ms

Detector function =peak & Average

Trace = max hold

5.1.2.4 Test Result and Test Equipment List

Please refer to ANNEX A.2.

NOTE:

1. Results (dBμV) = Reading (dBμV) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Margin = Limit - Results

ANNEX A TEST RESULTS

A.1 Radiated Emission

Note 1: The symbol of “--” in the table which means not application.

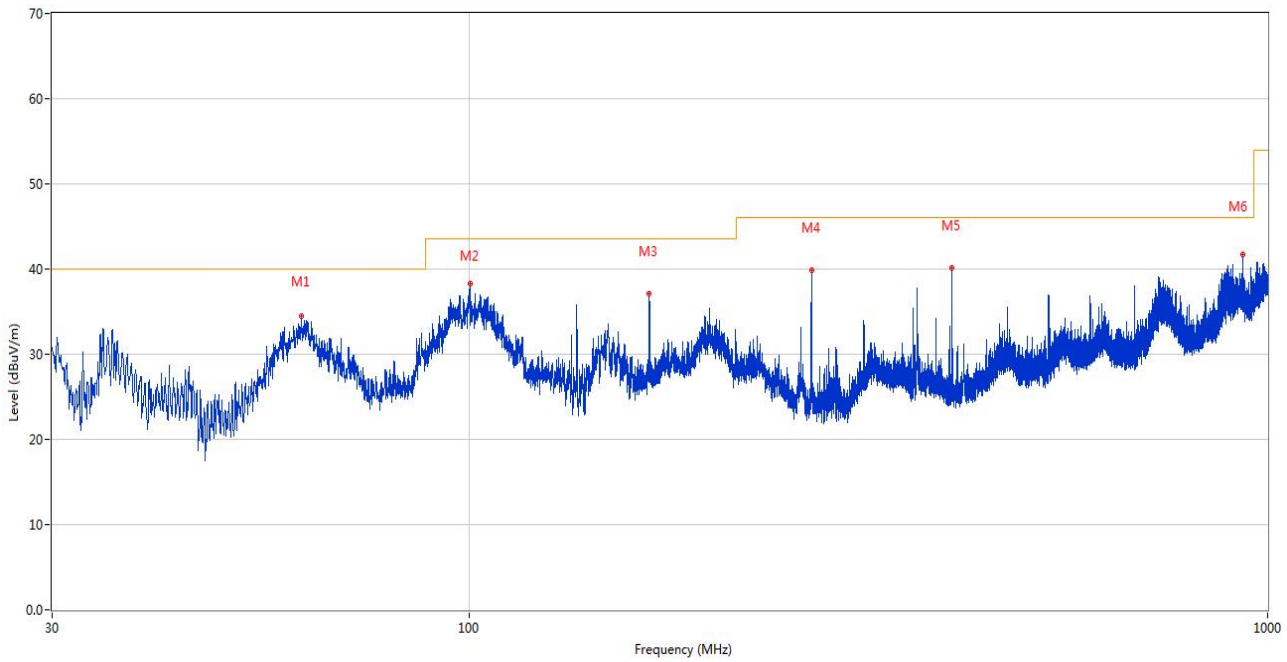
Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note 3: The Radiated Emission is required to be investigated to the upper frequency of 5th harmonic of the highest internal frequency of EUT or 40 GHz, whichever is lower. The test results above 18GHz are only noise and are not recorded in the report.

Sample No.	S01+A01+A05+A09+A13+A15	Temperature	21.8℃~23.5℃
Humidity	36%RH~42%RH	Pressure	101.4kPa~101.7kPa
Test Engineer	Li Jianping	Test Date	2026.01.05~2026.01.06

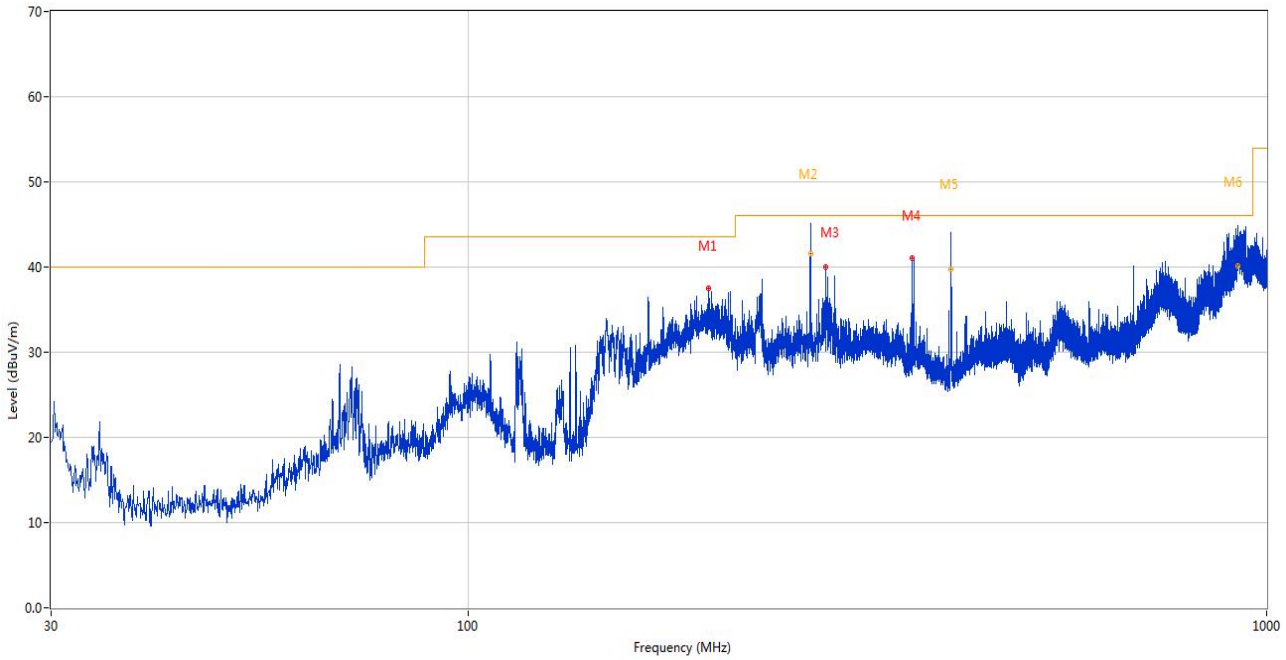
Test Mode 1

1) Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	61.574	34.45	-25.71	40.0	5.55	Peak	301.10	100	Vertical	Pass
2	100.228	38.29	-25.61	43.5	5.21	Peak	160.20	100	Vertical	Pass
3	167.982	37.04	-27.14	43.5	6.46	Peak	152.40	100	Vertical	Pass
4	268.280	39.81	-22.45	46.0	6.19	Peak	248.30	100	Vertical	Pass
5	402.334	40.16	-18.26	46.0	5.84	Peak	34.00	100	Vertical	Pass
6	932.197	41.74	-5.73	46.0	4.26	Peak	232.30	100	Vertical	Pass

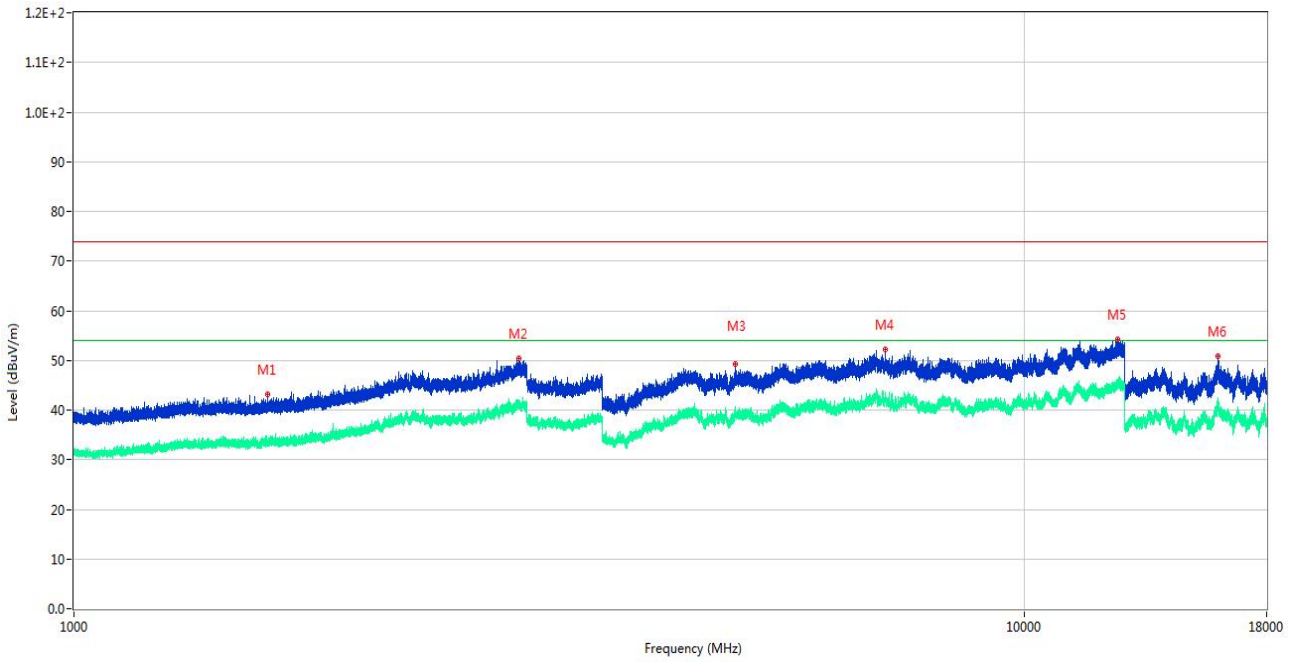
2) Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	199.992	37.45	-24.38	43.5	6.05	Peak	228.70	100	Horizontal	Pass
2	268.280	45.17	-22.45	46.0	0.83	Peak	116.10	100	Horizontal	N/A
2*	268.280	41.55	-22.45	46.0	4.45	QP	116.10	100	Horizontal	Pass
3	280.454	40.04	-21.97	46.0	5.96	Peak	163.00	100	Horizontal	Pass
4	359.994	41.05	-20.29	46.0	4.95	Peak	149.50	100	Horizontal	Pass
5	402.334	44.13	-18.26	46.0	1.87	Peak	242.80	100	Horizontal	N/A
5*	402.334	39.74	-18.26	46.0	6.26	QP	242.80	100	Horizontal	Pass
6	921.527	44.88	-5.86	46.0	1.12	Peak	263.40	100	Horizontal	N/A
6*	921.527	40.14	-5.86	46.0	5.86	QP	263.40	100	Horizontal	Pass

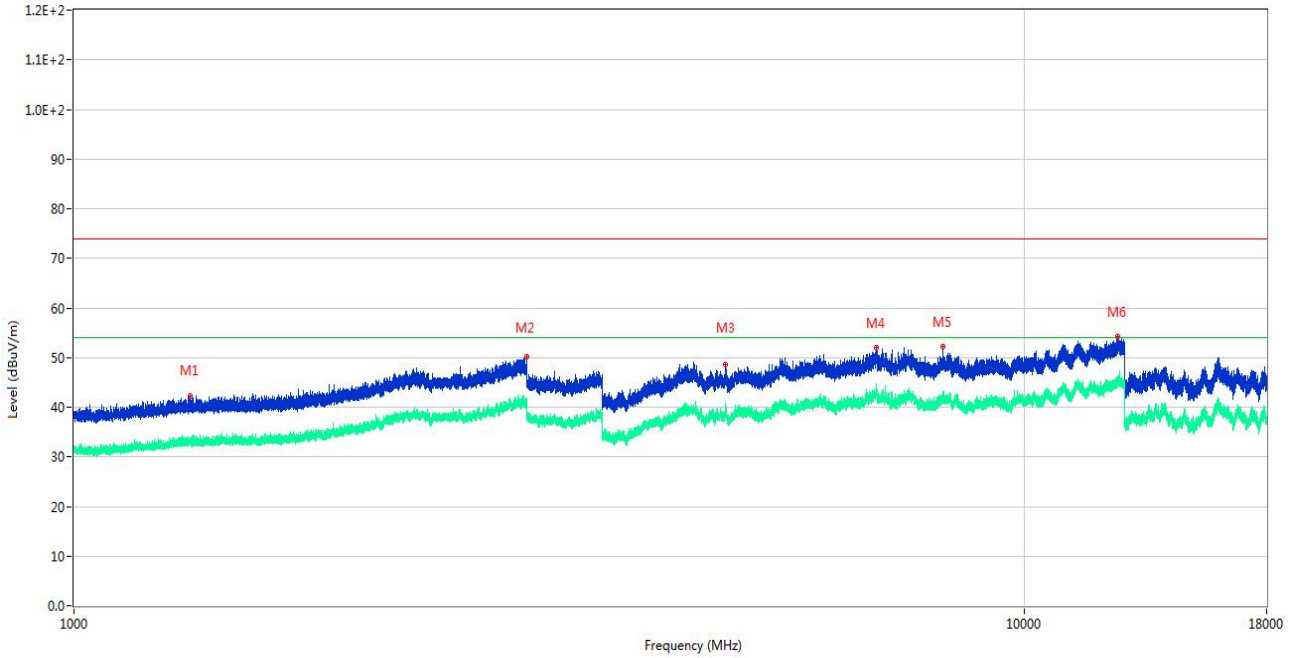
Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Below 1 GHz						
EMI Receiver	Keysight	N9038A	MY53220118	2025.06.16	2026.06.15	☒
Amplifier (30MHz-1GHz)	COM-MV	ZT30-1000M	B2017119082	2025.11.25	2026.11.24	☒
Test Antenna-Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2024.07.06	2027.07.05	☒
Anechoic Chamber（#5）	ChangChuang	9m*6m*6m	104-1	2025.10.13	2028.10.12	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

3) Test Antenna Vertical, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1600.200	43.08	-13.16	74.0	30.92	Peak	318.80	100	Vertical	Pass
1**	1600.200	33.20	-13.16	54.0	20.80	AV	318.80	100	Vertical	Pass
2	2936.200	50.36	-4.13	74.0	23.64	Peak	132.20	200	Vertical	Pass
2**	2936.200	41.88	-4.13	54.0	12.12	AV	132.20	200	Vertical	Pass
3	4967.000	49.30	-1.80	74.0	24.70	Peak	172.40	100	Vertical	Pass
3**	4967.000	39.10	-1.80	54.0	14.90	AV	172.40	100	Vertical	Pass
4	7141.737	52.27	20.05	74.0	21.73	Peak	4.60	100	Vertical	Pass
4**	7141.737	43.35	20.05	54.0	10.65	AV	4.60	100	Vertical	Pass
5	12532.938	54.15	22.37	74.0	19.85	Peak	208.70	200	Vertical	Pass
5**	12532.938	45.34	22.37	54.0	8.66	AV	208.70	200	Vertical	Pass
6	16000.538	50.81	26.01	74.0	23.19	Peak	216.20	100	Vertical	Pass
6**	16000.538	41.10	26.01	54.0	12.90	AV	216.20	100	Vertical	Pass

4) Test Antenna Horizontal, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1324.000	42.35	-13.41	74.0	31.65	Peak	97.40	100	Horizontal	Pass
1**	1324.000	33.17	-13.41	54.0	20.83	AV	97.40	100	Horizontal	Pass
2	2993.900	50.10	-3.53	74.0	23.90	Peak	97.40	200	Horizontal	Pass
2**	2993.900	40.58	-3.53	54.0	13.42	AV	97.40	200	Horizontal	Pass
3	4851.800	48.53	-0.88	74.0	25.47	Peak	0.00	200	Horizontal	Pass
3**	4851.800	38.78	-0.88	54.0	15.22	AV	0.00	200	Horizontal	Pass
4	6988.000	52.05	1.03	74.0	21.95	Peak	343.70	100	Horizontal	Pass
4**	6988.000	42.59	1.03	54.0	11.41	AV	343.70	100	Horizontal	Pass
5	8216.125	52.18	20.01	74.0	21.82	Peak	0.00	100	Horizontal	Pass
5**	8216.125	40.67	20.01	54.0	13.33	AV	0.00	100	Horizontal	Pass
6	12536.674	54.18	22.43	74.0	19.82	Peak	50.30	100	Horizontal	Pass
6**	12536.674	44.58	22.43	54.0	9.42	AV	50.30	100	Horizontal	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Above 1 GHz						
EMI Receiver	Keysight	N9038A	MY53220118	2025.06.16	2026.06.15	☒
EMI Receiver	R&S	FSV-40	101544	2025.10.30	2026.10.29	☒
Amplifier (1-12GHz)	COM-MV	DLNAB-1000-12000-002	18080279	2025.11.25	2026.11.24	☒
Amplifier （0.8-21GHz）	Mini-Circuits	ZVA-213-S+	619201336	2025.11.25	2026.11.24	☒
Amplifier (18-40GHz)	COM-MV	KA_LNA18-40G-01	18050001	2024.06.15	2027.06.14	☒
Test Antenna-Horn	SCHWARZBECK	BBHA 9120D	1148	2025.05.28	2028.05.27	☒
Test Antenna-Horn	A-INFOMW	LB-180400KF	J211060273	2024.06.15	2027.06.14	☒
Anechoic Chamber（#5）	ChangChuang	9m*6m*6m	104-1	2025.10.13	2028.10.12	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

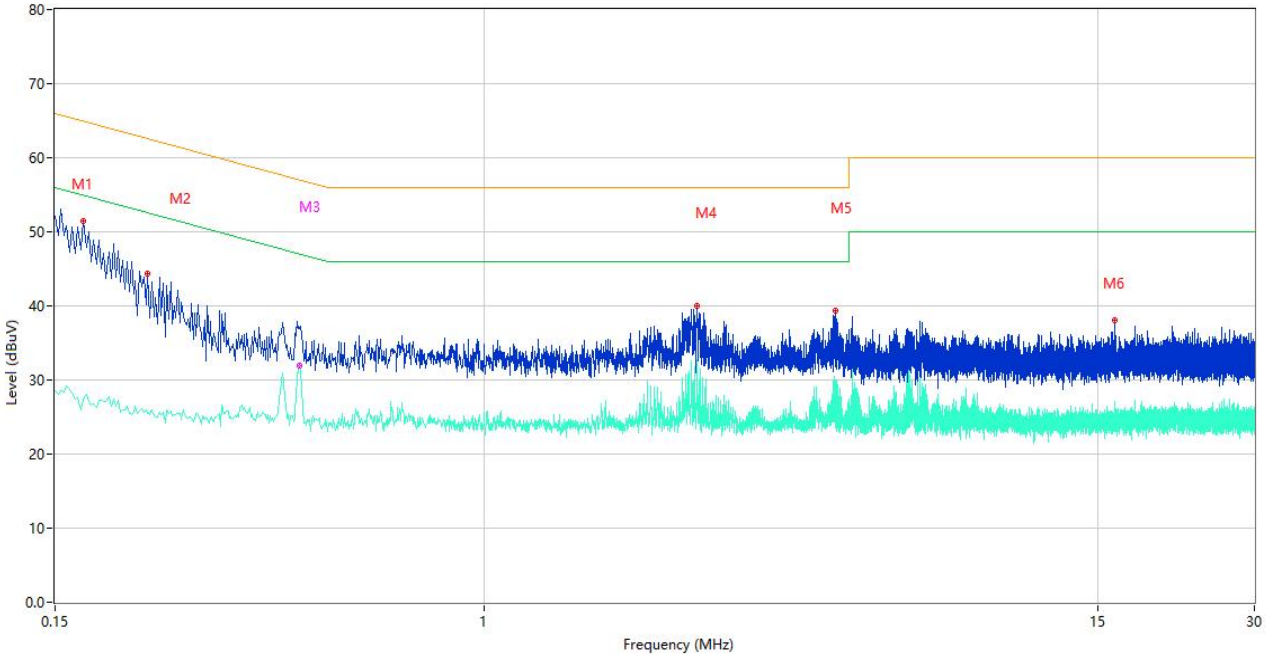
A.2 Conducted Emission, AC Ports

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (240 VAC, 50 Hz) shown here.

Sample No.	S01+A01+A05+A09+A13+A15	Temperature	19.3℃
Humidity	39%RH	Pressure	101.4kPa
Test Engineer	Huang Penghui	Test Date	2026.01.06

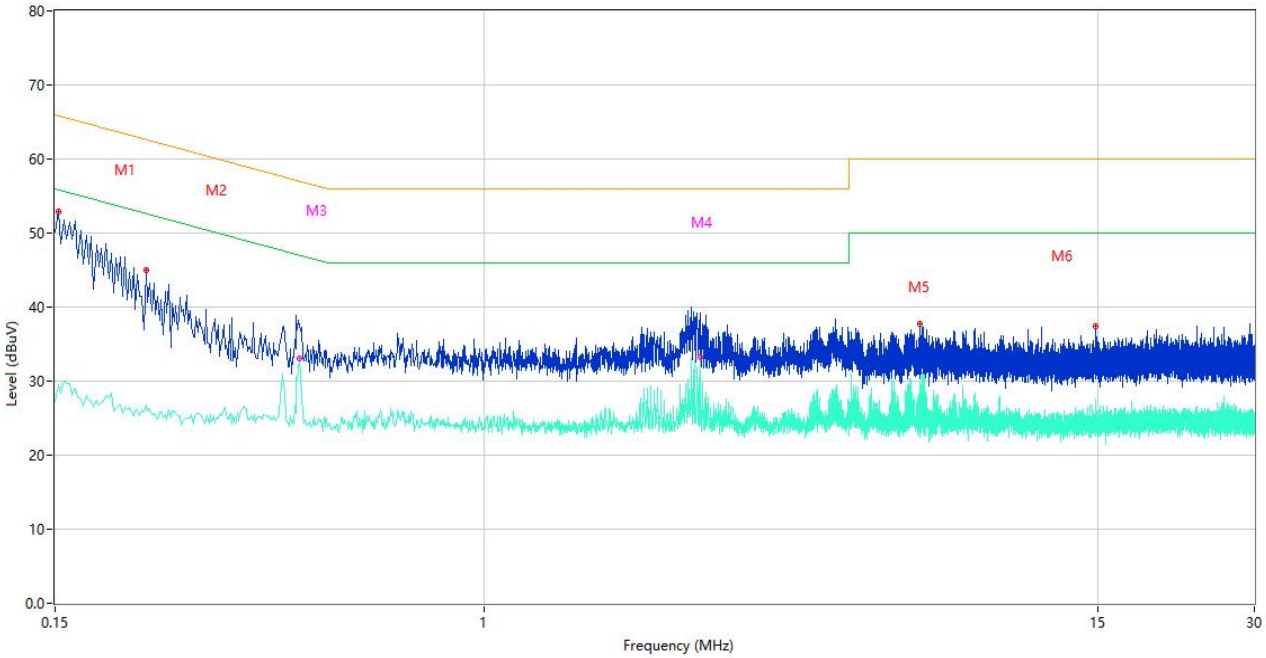
Test Mode 1

1) AC Ports - L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.170	51.39	9.85	64.96	13.57	Peak	L	Pass
1**	0.170	27.36	9.85	54.96	27.60	AV	L	Pass
2	0.226	44.40	9.83	62.60	18.20	Peak	L	Pass
2**	0.226	25.50	9.83	52.60	27.10	AV	L	Pass
3	0.442	36.90	10.17	57.02	20.12	Peak	L	Pass
3**	0.442	31.89	10.17	47.02	15.13	AV	L	Pass
4	2.556	40.06	10.07	56.00	15.94	Peak	L	Pass
4**	2.556	32.77	10.07	46.00	13.23	AV	L	Pass
5	4.704	39.33	10.17	56.00	16.67	Peak	L	Pass
5**	4.704	28.54	10.17	46.00	17.46	AV	L	Pass
6	16.194	38.09	10.79	60.00	21.91	Peak	L	Pass
6**	16.194	26.07	10.79	50.00	23.93	AV	L	Pass

2) AC Ports - N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.152	52.85	9.86	65.89	13.04	Peak	N	Pass
1**	0.152	29.55	9.86	55.89	26.34	AV	N	Pass
2	0.224	44.95	9.83	62.67	17.72	Peak	N	Pass
2**	0.224	26.74	9.83	52.67	25.93	AV	N	Pass
3	0.442	37.50	10.17	57.02	19.52	Peak	N	Pass
3**	0.442	33.03	10.17	47.02	13.99	AV	N	Pass
4	2.590	39.19	9.78	56.00	16.81	Peak	N	Pass
4**	2.590	33.19	9.78	46.00	12.81	AV	N	Pass
5	6.858	37.68	10.23	60.00	22.32	Peak	N	Pass
5**	6.858	22.36	10.23	50.00	27.64	AV	N	Pass
6	14.882	37.43	10.83	60.00	22.57	Peak	N	Pass
6**	14.882	27.44	10.83	50.00	22.56	AV	N	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9010B	MY57110309	2025.06.16	2026.06.15	☒
LISN	SCHWARZBECK	NSLK 8127	8127-687	2025.04.29	2026.04.28	☒
Shielded Room	Chang Chuang	4*4*3m	662	2025.10.12	2028.10.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.930	/		☒

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ25C1198-AE.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-SZ25C1198-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-SZ25C1198-AI.PDF”.

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